

Search Notes



Application/Control No.

10/751,306

Examiner

Mark A. Chapman

Applicant(s)/Patent under
Reexamination

MIYAKAWA ET AL.

Art Unit

1756

SEARCHED

Class	Subclass	Date	Examiner
399	228	12/8/2005	MC
	231		
430	45		
	47		
	111.4		
	107.1		
	126		
update		4/06	m.c.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
430	45	4/06	m.c.
	47		
	111.4		
	107.1		
	126		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
east	12/8/2005	MC
reviewed related applications		
update	4/06	m.c.